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**LM317MDT D-Pak
Qualification Package**

Fall 1999

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Introduction

Introduction

General Product Description

The LM317MDT is a 3-terminal positive voltage regulator capable of supplying 500mA over a 1.2V to 37V output range in the D-Pak (TO-252) package. It is exceptionally easy to use and requires only two external resistors to set the output voltage. Included on the chip are current limit, thermal overload protection, and safe area protection.

Reliability/Qualification Overview

The TO-252 package underwent a variety of tests to qualify this new package at National Semiconductor. The package successfully passed autoclave, high temperature storage, static operating life, temperature humidity bias, temperature cycle, and power cycle testing and has been qualified as a level one moisture sensitive package. Refer to the reliability report included in this booklet for further information about the qualification.

Technical Assistance

Americas

Tel: 1-800-272-9959

Fax: 1-800-737-7018

Email: support@nsc.com

Europe

Fax: +49 (0) 1 80 5 30 85 86

Email: europe.support@nsc.com

Deutsch Tel: +49 (0) 1 80 5 30 85 85

English Tel: +49 (0) 1 80 5 32 78 32

Japan

Tel: 81-3-5639-7560

Fax: 81-3-5639-7507

Asia Pacific

Fax: 65-2504466

Email: sea.support@nsc.com

Tel: 65-2544466

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Datasheet

LM117/LM317A/LM317

3-Terminal Adjustable Regulator

General Description

The LM117 series of adjustable 3-terminal positive voltage regulators is capable of supplying in excess of 1.5A over a 1.2V to 37V output range. They are exceptionally easy to use and require only two external resistors to set the output voltage. Further, both line and load regulation are better than standard fixed regulators. Also, the LM117 is packaged in standard transistor packages which are easily mounted and handled.

In addition to higher performance than fixed regulators, the LM117 series offers full overload protection available only in IC's. Included on the chip are current limit, thermal overload protection and safe area protection. All overload protection circuitry remains fully functional even if the adjustment terminal is disconnected.

Normally, no capacitors are needed unless the device is situated more than 6 inches from the input filter capacitors in which case an input bypass is needed. An optional output capacitor can be added to improve transient response. The adjustment terminal can be bypassed to achieve very high ripple rejection ratios which are difficult to achieve with standard 3-terminal regulators.

Besides replacing fixed regulators, the LM117 is useful in a wide variety of other applications. Since the regulator is "floating" and sees only the input-to-output differential volt-

age, supplies of several hundred volts can be regulated as long as the maximum input to output differential is not exceeded, i.e., avoid short-circuiting the output.

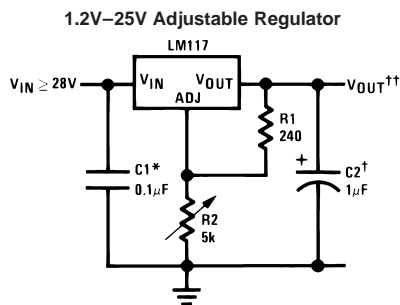
Also, it makes an especially simple adjustable switching regulator, a programmable output regulator, or by connecting a fixed resistor between the adjustment pin and output, the LM117 can be used as a precision current regulator. Supplies with electronic shutdown can be achieved by clamping the adjustment terminal to ground which programs the output to 1.2V where most loads draw little current.

For applications requiring greater output current, see LM150 series (3A) and LM138 series (5A) data sheets. For the negative complement, see LM137 series data sheet.

Features

- Guaranteed 1% output voltage tolerance (LM317A)
- Guaranteed max. 0.01%/V line regulation (LM317A)
- Guaranteed max. 0.3% load regulation (LM117)
- Guaranteed 1.5A output current
- Adjustable output down to 1.2V
- Current limit constant with temperature
- P+ Product Enhancement tested
- 80 dB ripple rejection
- Output is short-circuit protected

Typical Applications



Full output current not available at high input-output voltages

*Needed if device is more than 6 inches from filter capacitors.

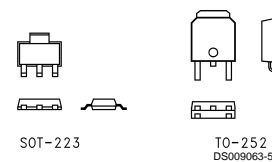
†Optional — improves transient response. Output capacitors in the range of 1 μF to 1000 μF of aluminum or tantalum electrolytic are commonly used to provide improved output impedance and rejection of transients.

$$\dagger\dagger V_{OUT} = 1.25V \left(1 + \frac{R2}{R1} \right) + I_{ADJ}(R2)$$

LM117 Series Packages

Part Number Suffix	Package	Design Load Current
K	TO-3	1.5A
H	TO-39	0.5A
T	TO-220	1.5A
E	LCC	0.5A
S	TO-263	1.5A
EMP	SOT-223	1A
MDT	TO-252	0.5A

SOT-223 vs D-Pak (TO-252) Packages



Scale 1:1

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Power Dissipation	Internally Limited
Input-Output Voltage Differential	+40V, -0.3V
Storage Temperature	-65°C to +150°C
Lead Temperature	
Metal Package (Soldering, 10 seconds)	300°C
Plastic Package (Soldering, 4 seconds)	260°C
ESD Tolerance (Note 5)	3 kV

Operating Temperature Range

LM117	-55°C ≤ T _J ≤ +150°C
LM317A	-40°C ≤ T _J ≤ +125°C
LM317	0°C ≤ T _J ≤ +125°C

Preconditioning

Thermal Limit Burn-In	All Devices 100%
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Electrical Characteristics (Note 3)

Specifications with standard type face are for T_J = 25°C, and those with **boldface type** apply over full Operating Temperature Range. Unless otherwise specified, V_{IN} - V_{OUT} = 5V, and I_{OUT} = 10 mA.

Parameter	Conditions	LM117 (Note 2)			Units	
		Min	Typ	Max		
Reference Voltage					V	
	3V ≤ (V _{IN} - V _{OUT}) ≤ 40V, 10 mA ≤ I _{OUT} ≤ I _{MAX} , P ≤ P _{MAX}	1.20	1.25	1.30	V	
Line Regulation	3V ≤ (V _{IN} - V _{OUT}) ≤ 40V (Note 4)		0.01	0.02	%/V	
			0.02	0.05	%/V	
Load Regulation	10 mA ≤ I _{OUT} ≤ I _{MAX} (Note 4)		0.1	0.3	%	
			0.3	1	%	
Thermal Regulation	20 ms Pulse		0.03	0.07	%/W	
Adjustment Pin Current			50	100	µA	
Adjustment Pin Current Change	10 mA ≤ I _{OUT} ≤ I _{MAX} 3V ≤ (V _{IN} - V _{OUT}) ≤ 40V		0.2	5	µA	
Temperature Stability	T _{MIN} ≤ T _J ≤ T _{MAX}		1		%	
Minimum Load Current	(V _{IN} - V _{OUT}) = 40V		3.5	5	mA	
Current Limit	(V _{IN} - V _{OUT}) ≤ 15V	K Package	1.5	2.2	3.4	A
		H Packages	0.5	0.8	1.8	A
	(V _{IN} - V _{OUT}) = 40V	K Package	0.3	0.4		A
		H Package	0.15	0.2		A
RMS Output Noise, % of V _{OUT}	10 Hz ≤ f ≤ 10 kHz		0.003		%	
Ripple Rejection Ratio	V _{OUT} = 10V, f = 120 Hz, C _{ADJ} = 0 µF		65		dB	
	V _{OUT} = 10V, f = 120 Hz, C _{ADJ} = 10 µF	66	80		dB	
Long-Term Stability	T _J = 125°C, 1000 hrs		0.3	1	%	
Thermal Resistance, Junction-to-Case	K Package		2.3	3	°C/W	
	H Package		12	15	°C/W	
	E Package				°C/W	
Thermal Resistance, Junction-to-Ambient (No Heat Sink)	K Package		35		°C/W	
	H Package		140		°C/W	
	E Package				°C/W	

Electrical Characteristics (Note 3)

Specifications with standard type face are for $T_J = 25^\circ\text{C}$, and those with **boldface type** apply over **full Operating Temperature Range**. Unless otherwise specified, $V_{IN} - V_{OUT} = 5\text{V}$, and $I_{OUT} = 10\text{ mA}$.

Parameter	Conditions	LM317A			LM317			Units	
		Min	Typ	Max	Min	Typ	Max		
Reference Voltage		1.238	1.250	1.262				V	
	$3\text{V} \leq (V_{IN} - V_{OUT}) \leq 40\text{V}$, $10\text{ mA} \leq I_{OUT} \leq I_{MAX}$, $P \leq P_{MAX}$	1.225	1.250	1.270	1.20	1.25	1.30	V	
Line Regulation	$3\text{V} \leq (V_{IN} - V_{OUT}) \leq 40\text{V}$ (Note 4)		0.005	0.01		0.01	0.04	%/V	
			0.01	0.02		0.02	0.07	%/V	
Load Regulation	$10\text{ mA} \leq I_{OUT} \leq I_{MAX}$ (Note 4)		0.1	0.5		0.1	0.5	%	
			0.3	1		0.3	1.5	%	
Thermal Regulation	20 ms Pulse		0.04	0.07		0.04	0.07	%/W	
Adjustment Pin Current			50	100		50	100	μA	
Adjustment Pin Current Change	$10\text{ mA} \leq I_{OUT} \leq I_{MAX}$ $3\text{V} \leq (V_{IN} - V_{OUT}) \leq 40\text{V}$		0.2	5		0.2	5	μA	
Temperature Stability	$T_{MIN} \leq T_J \leq T_{MAX}$		1			1		%	
Minimum Load Current	$(V_{IN} - V_{OUT}) = 40\text{V}$		3.5	10		3.5	10	mA	
Current Limit	$(V_{IN} - V_{OUT}) \leq 15\text{V}$ K, T, S Packages H Package MP Package		1.5	2.2	3.4	1.5	2.2	3.4	A
			0.5	0.8	1.8	0.5	0.8	1.8	A
			1.5	2.2	3.4	1.5	2.2	3.4	A
	$(V_{IN} - V_{OUT}) = 40\text{V}$ K, T, S Packages H Package MP Package		0.15	0.4		0.15	0.4		A
			0.075	0.2		0.075	0.2		A
			0.55	0.4		0.15	0.4		A
RMS Output Noise, % of V_{OUT}	$10\text{ Hz} \leq f \leq 10\text{ kHz}$		0.003			0.003		%	
Ripple Rejection Ratio	$V_{OUT} = 10\text{V}$, $f = 120\text{ Hz}$, $C_{ADJ} = 0\text{ }\mu\text{F}$		65			65		dB	
	$V_{OUT} = 10\text{V}$, $f = 120\text{ Hz}$, $C_{ADJ} = 10\text{ }\mu\text{F}$	66	80		66	80		dB	
Long-Term Stability	$T_J = 125^\circ\text{C}$, 1000 hrs		0.3	1		0.3	1	%	
Thermal Resistance, Junction-to-Case	K Package					2.3	3	$^\circ\text{C/W}$	
	MDT Package					5		$^\circ\text{C/W}$	
	H Package		12	15		12	15	$^\circ\text{C/W}$	
	T Package		4	5		4		$^\circ\text{C/W}$	
	MP Package		23.5			23.5		$^\circ\text{C/W}$	
Thermal Resistance, Junction-to-Ambient (No Heat Sink)	K Package		35			35		$^\circ\text{C/W}$	
	MDT Package (Note 6)					92		$^\circ\text{C/W}$	
	H Package		140			140		$^\circ\text{C/W}$	
	T Package		50			50		$^\circ\text{C/W}$	
	S Package (Note 6)		50			50		$^\circ\text{C/W}$	

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed.

Note 2: Refer to RETS117H drawing for the LM117H, or the RETS117K for the LM117K military specifications.

Note 3: Although power dissipation is internally limited, these specifications are applicable for maximum power dissipations of 2W for the TO-39 and SOT-223 and 20W for the TO-3, TO-220, and TO-263. I_{MAX} is 1.5A for the TO-3, TO-220, and TO-263 packages, 0.5A for the TO-39 package and 1A for the SOT-223 Package. All limits (i.e., the numbers in the Min. and Max. columns) are guaranteed to National's AOQL (Average Outgoing Quality Level).

Note 4: Regulation is measured at a constant junction temperature, using pulse testing with a low duty cycle. Changes in output voltage due to heating effects are covered under the specifications for thermal regulation.

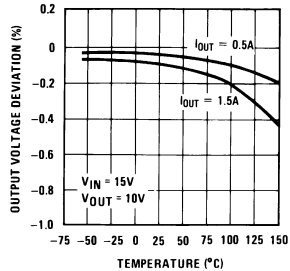
Note 5: Human body model, 100 pF discharged through a 1.5 k Ω resistor.

Note 6: If the TO-263 or TO-252 packages are used, the thermal resistance can be reduced by increasing the PC board copper area thermally connected to the package. If the SOT-223 package is used, the thermal resistance can be reduced by increasing the PC board copper area (see applications hints for heatsinking).

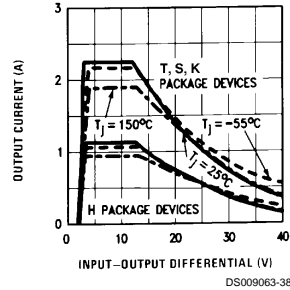
Typical Performance Characteristics

Output Capacitor = 0 μ F unless otherwise noted

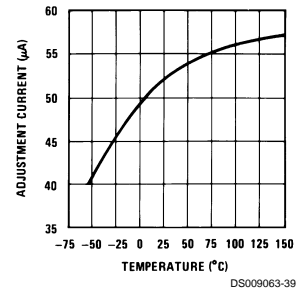
Load Regulation



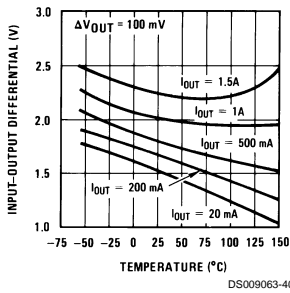
Current Limit



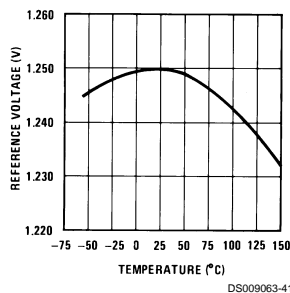
Adjustment Current



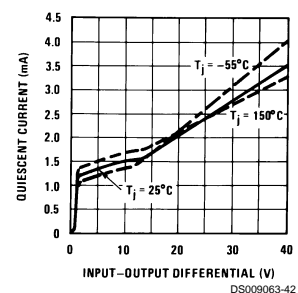
Dropout Voltage



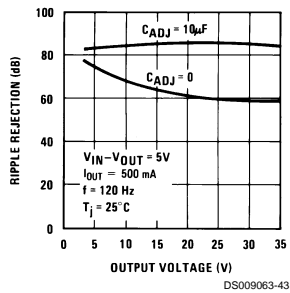
Temperature Stability



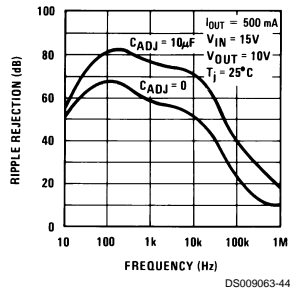
Minimum Operating Current



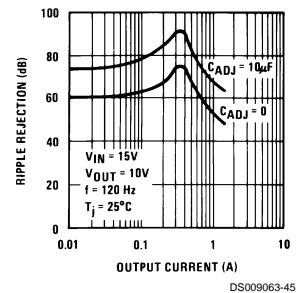
Ripple Rejection



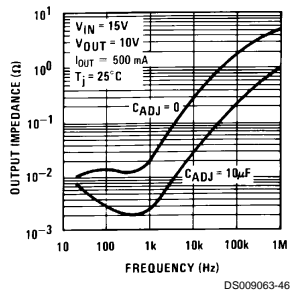
Ripple Rejection



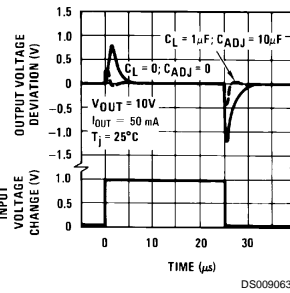
Ripple Rejection



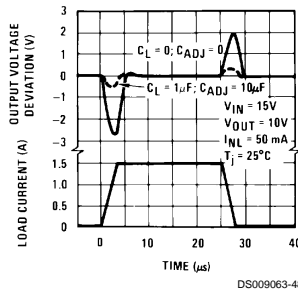
Output Impedance



Line Transient Response



Load Transient Response



Application Hints

In operation, the LM117 develops a nominal 1.25V reference voltage, V_{REF} , between the output and adjustment terminal. The reference voltage is impressed across program resistor R1 and, since the voltage is constant, a constant current I_1 then flows through the output set resistor R2, giving an output voltage of

$$V_{OUT} = V_{REF} \left(1 + \frac{R2}{R1} \right) + I_{ADJ}R2$$

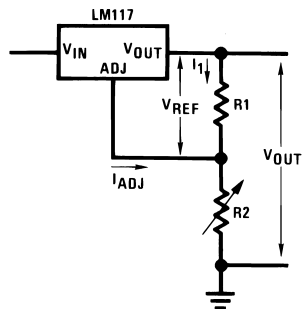


FIGURE 1.

Since the 100 μ A current from the adjustment terminal represents an error term, the LM117 was designed to minimize I_{ADJ} and make it very constant with line and load changes. To do this, all quiescent operating current is returned to the output establishing a minimum load current requirement. If there is insufficient load on the output, the output will rise.

External Capacitors

An input bypass capacitor is recommended. A 0.1 μ F disc or 1 μ F solid tantalum on the input is suitable input bypassing for almost all applications. The device is more sensitive to the absence of input bypassing when adjustment or output capacitors are used but the above values will eliminate the possibility of problems.

The adjustment terminal can be bypassed to ground on the LM117 to improve ripple rejection. This bypass capacitor prevents ripple from being amplified as the output voltage is increased. With a 10 μ F bypass capacitor 80 dB ripple rejection is obtainable at any output level. Increases over 10 μ F do not appreciably improve the ripple rejection at frequencies above 120 Hz. If the bypass capacitor is used, it is sometimes necessary to include protection diodes to prevent the capacitor from discharging through internal low current paths and damaging the device.

In general, the best type of capacitors to use is solid tantalum. Solid tantalum capacitors have low impedance even at high frequencies. Depending upon capacitor construction, it takes about 25 μ F in aluminum electrolytic to equal 1 μ F solid tantalum at high frequencies. Ceramic capacitors are also good at high frequencies; but some types have a large decrease in capacitance at frequencies around 0.5 MHz. For this reason, 0.01 μ F disc may seem to work better than a 0.1 μ F disc as a bypass.

Although the LM117 is stable with no output capacitors, like any feedback circuit, certain values of external capacitance can cause excessive ringing. This occurs with values between 500 pF and 5000 pF. A 1 μ F solid tantalum (or 25 μ F

aluminum electrolytic) on the output swamps this effect and insures stability. Any increase of the load capacitance larger than 10 μ F will merely improve the loop stability and output impedance.

Load Regulation

The LM117 is capable of providing extremely good load regulation but a few precautions are needed to obtain maximum performance. The current set resistor connected between the adjustment terminal and the output terminal (usually 240 Ω) should be tied directly to the output (case) of the regulator rather than near the load. This eliminates line drops from appearing effectively in series with the reference and degrading regulation. For example, a 15V regulator with 0.05 Ω resistance between the regulator and load will have a load regulation due to line resistance of 0.05 Ω x I_L . If the set resistor is connected near the load the effective line resistance will be 0.05 Ω (1 + R2/R1) or in this case, 11.5 times worse.

Figure 2 shows the effect of resistance between the regulator and 240 Ω set resistor.

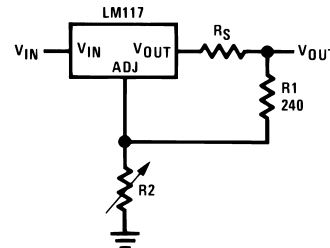


FIGURE 2. Regulator with Line Resistance in Output Lead

With the TO-3 package, it is easy to minimize the resistance from the case to the set resistor, by using two separate leads to the case. However, with the TO-39 package, care should be taken to minimize the wire length of the output lead. The ground of R2 can be returned near the ground of the load to provide remote ground sensing and improve load regulation.

Protection Diodes

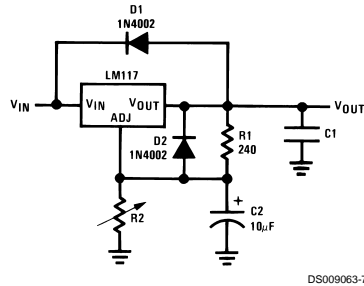
When external capacitors are used with any IC regulator it is sometimes necessary to add protection diodes to prevent the capacitors from discharging through low current points into the regulator. Most 10 μ F capacitors have low enough internal series resistance to deliver 20A spikes when shorted. Although the surge is short, there is enough energy to damage parts of the IC.

When an output capacitor is connected to a regulator and the input is shorted, the output capacitor will discharge into the output of the regulator. The discharge current depends on the value of the capacitor, the output voltage of the regulator, and the rate of decrease of V_{IN} . In the LM117, this discharge path is through a large junction that is able to sustain 15A surge with no problem. This is not true of other types of positive regulators. For output capacitors of 25 μ F or less, there is no need to use diodes.

The bypass capacitor on the adjustment terminal can discharge through a low current junction. Discharge occurs when either the input or output is shorted. Internal to the LM117 is a 50 Ω resistor which limits the peak discharge current. No protection is needed for output voltages of 25V or

Application Hints (Continued)

less and 10 μF capacitance. *Figure 3* shows an LM117 with protection diodes included for use with outputs greater than 25V and high values of output capacitance.



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$$V_{OUT} = 1.25V \left(1 + \frac{R_2}{R_1} \right) + I_{ADJ}R_2$$

D1 protects against C1
D2 protects against C2

FIGURE 3. Regulator with Protection Diodes

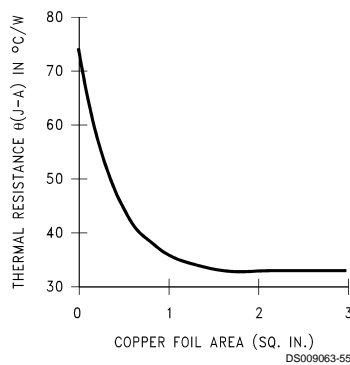
When a value for $\theta_{(H-A)}$ is found using the equation shown, a heatsink must be selected that has a value that is less than or equal to this number.

$\theta_{(H-A)}$ is specified numerically by the heatsink manufacturer in the catalog, or shown in a curve that plots temperature rise vs power dissipation for the heatsink.

HEATSINKING TO-263, SOT-223 AND TO-252 PACKAGE PARTS

The TO-263 ("S"), SOT-223 ("MP") and TO-252 ("DT") packages use a copper plane on the PCB and the PCB itself as a heatsink. To optimize the heat sinking ability of the plane and PCB, solder the tab of the package to the plane.

Figure 4 shows for the TO-263 the measured values of $\theta_{(J-A)}$ for different copper area sizes using a typical PCB with 1 ounce copper and no solder mask over the copper area used for heatsinking.

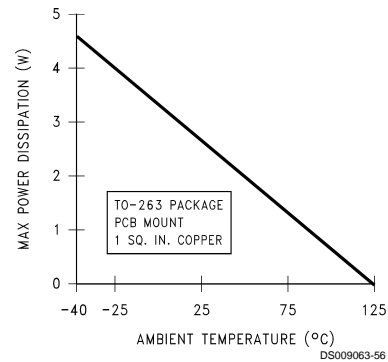


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FIGURE 4. $\theta_{(J-A)}$ vs Copper (1 ounce) Area for the TO-263 Package

As shown in the figure, increasing the copper area beyond 1 square inch produces very little improvement. It should also be observed that the minimum value of $\theta_{(J-A)}$ for the TO-263 package mounted to a PCB is 32°C/W.

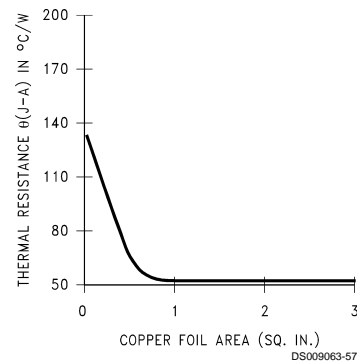
As a design aid, *Figure 5* shows the maximum allowable power dissipation compared to ambient temperature for the TO-263 device (assuming $\theta_{(J-A)}$ is 35°C/W and the maximum junction temperature is 125°C).



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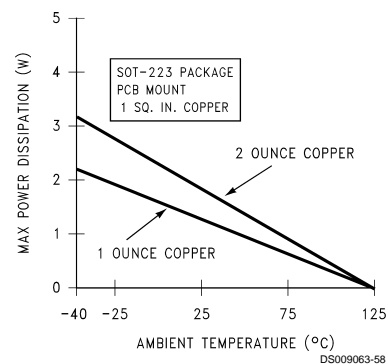
FIGURE 5. Maximum Power Dissipation vs T_{AMB} for the TO-263 Package

Figure 6 and *Figure 7* show the information for the SOT-223 package. *Figure 7* assumes a $\theta_{(J-A)}$ of 74°C/W for 1 ounce copper and 51°C/W for 2 ounce copper and a maximum junction temperature of 125°C.



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FIGURE 6. $\theta_{(J-A)}$ vs Copper (2 ounce) Area for the SOT-223 Package



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FIGURE 7. Maximum Power Dissipation vs T_{AMB} for the SOT-223 Package

Application Hints (Continued)

The LM317 regulators have internal thermal shutdown to protect the device from over-heating. Under all possible operating conditions, the junction temperature of the LM317 must be within the range of 0°C to 125°C. A heatsink may be required depending on the maximum power dissipation and maximum ambient temperature of the application. To determine if a heatsink is needed, the power dissipated by the regulator, P_D , must be calculated:

$$I_{IN} = I_L + I_G$$

$$P_D = (V_{IN} - V_{OUT}) I_L + V_{IN} I_G$$

Figure 8 shows the voltage and currents which are present in the circuit.

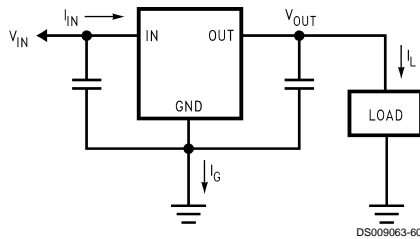


FIGURE 8. Power Dissipation Diagram

The next parameter which must be calculated is the maximum allowable temperature rise, $T_R(\max)$:

$$T_R(\max) = T_J(\max) - T_A(\max)$$

where $T_J(\max)$ is the maximum allowable junction temperature (125°C), and $T_A(\max)$ is the maximum ambient temperature which will be encountered in the application.

Using the calculated values for $T_R(\max)$ and P_D , the maximum allowable value for the junction-to-ambient thermal resistance (θ_{JA}) can be calculated:

$$\theta_{JA} = T_R(\max)/P_D$$

If the maximum allowable value for θ_{JA} is found to be $\geq 92^\circ\text{C/W}$ (Typical Rated Value) for TO-252 package, no heatsink is needed since the package alone will dissipate enough heat to satisfy these requirements. If the calculated value for θ_{JA} falls below these limits, a heatsink is required.

As a design aid, Table 1 shows the value of the θ_{JA} of TO-252 for different heatsink area. The copper patterns that we used to measure these θ_{JA} s are shown at the end of the Application Notes Section. Figure 9 reflects the same test results as what are in the Table 1

Figure 10 shows the maximum allowable power dissipation vs. ambient temperature for the TO-252 device. Figure 11 shows the maximum allowable power dissipation vs. copper area (in^2) for the TO-252 device. Please see AN1028 for power enhancement techniques to be used with SOT-223 and TO-252 packages.

TABLE 1. θ_{JA} Different Heatsink Area

Layout	Copper Area		Thermal Resistance ($\theta_{JA}^\circ\text{C/W}$) TO-252
	Top Side (in^2)*	Bottom Side (in^2)	
1	0.0123	0	103
2	0.066	0	87
3	0.3	0	60
4	0.53	0	54
5	0.76	0	52
6	1	0	47
7	0	0.2	84
8	0	0.4	70
9	0	0.6	63
10	0	0.8	57
11	0	1	57
12	0.066	0.066	89
13	0.175	0.175	72
14	0.284	0.284	61
15	0.392	0.392	55
16	0.5	0.5	53

Note: * Tab of device attached to top side of copper.

Application Hints (Continued)

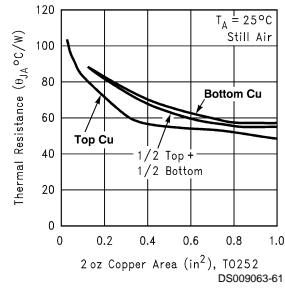


FIGURE 9. θ_{JA} vs 2oz Copper Area for TO-252

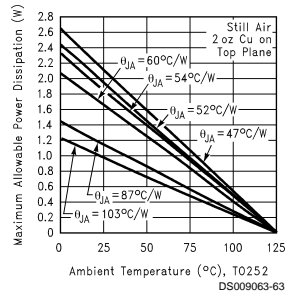


FIGURE 10. Maximum Allowable Power Dissipation vs. Ambient Temperature for TO-252

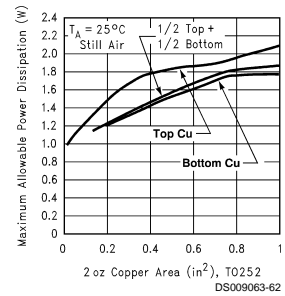


FIGURE 11. Maximum Allowable Power Dissipation vs. 2oz Copper Area for TO-252

Application Hints (Continued)

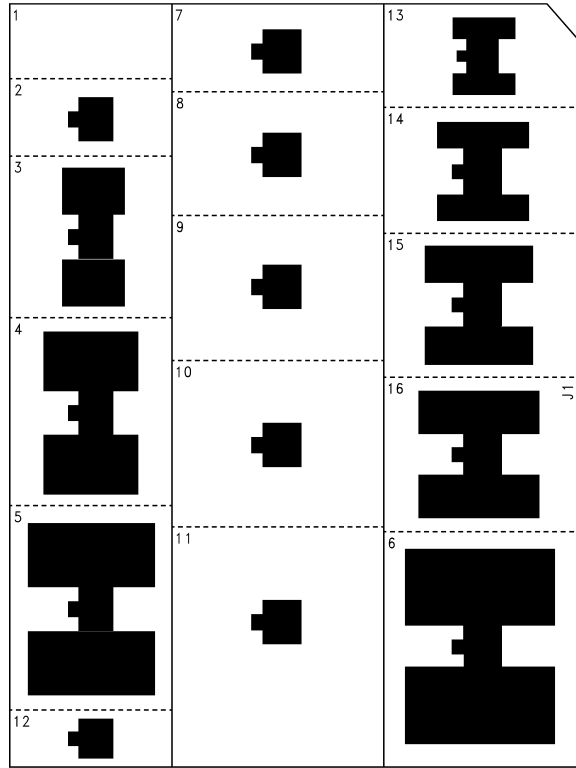
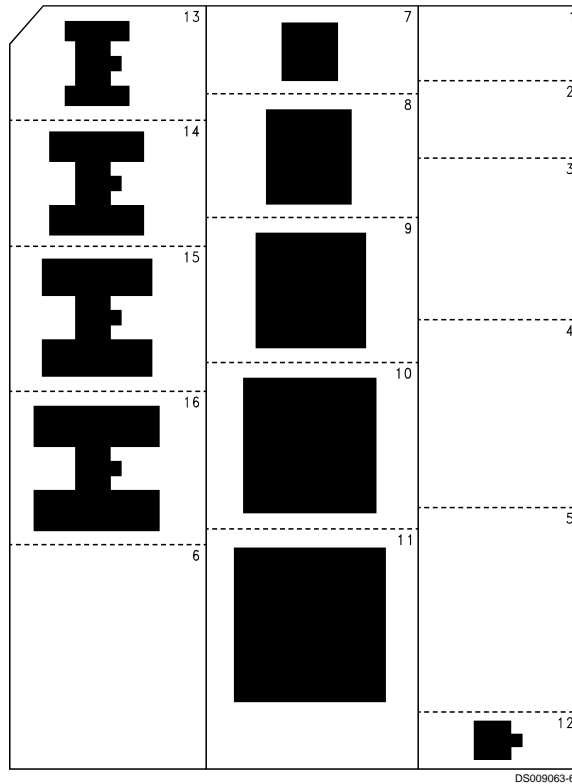


FIGURE 12. Top View of the Thermal Test Pattern in Actual Scale

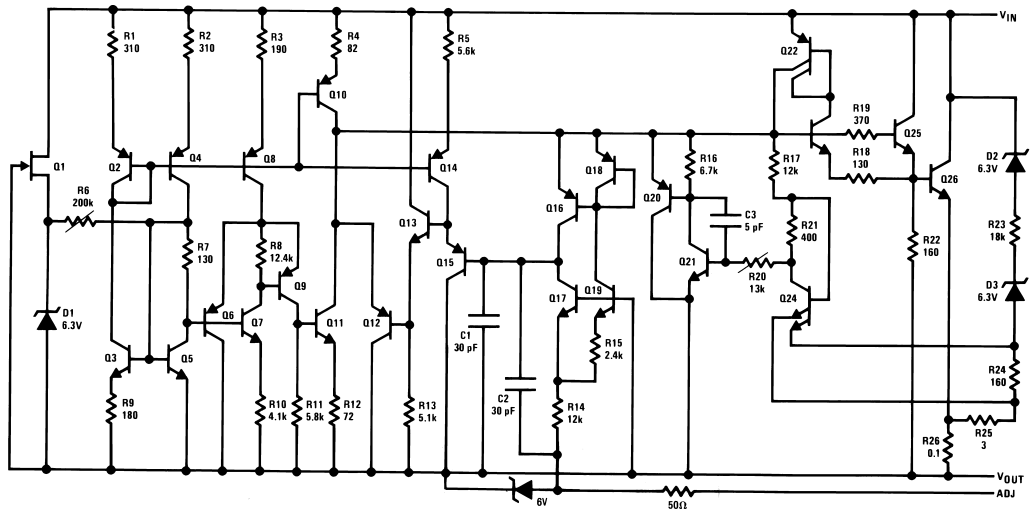
Application Hints (Continued)



DS009063-65

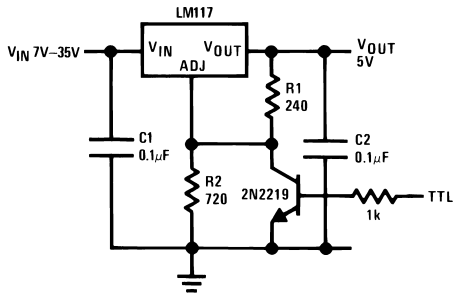
FIGURE 13. Bottom View of the Thermal Test Pattern in Actual Scale

Schematic Diagram



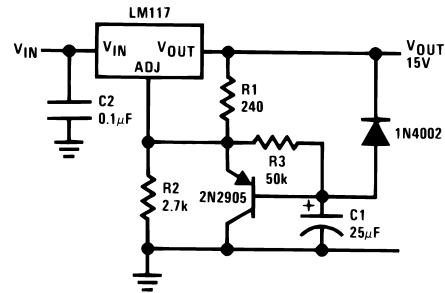
Typical Applications

5V Logic Regulator with Electronic Shutdown*



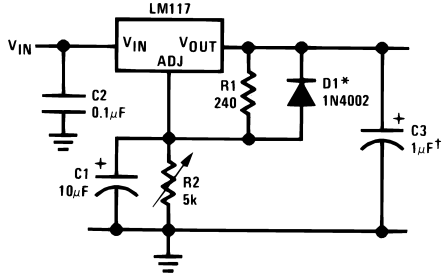
*Min. output \approx 1.2V

Slow Turn-On 15V Regulator



Typical Applications (Continued)

Adjustable Regulator with Improved Ripple Rejection

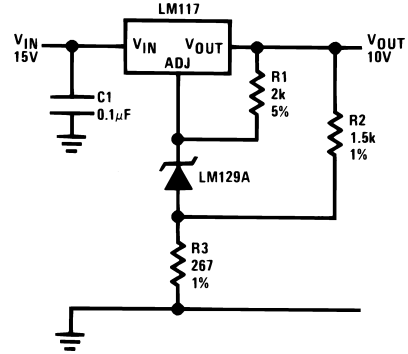


DS009063-10

†Solid tantalum

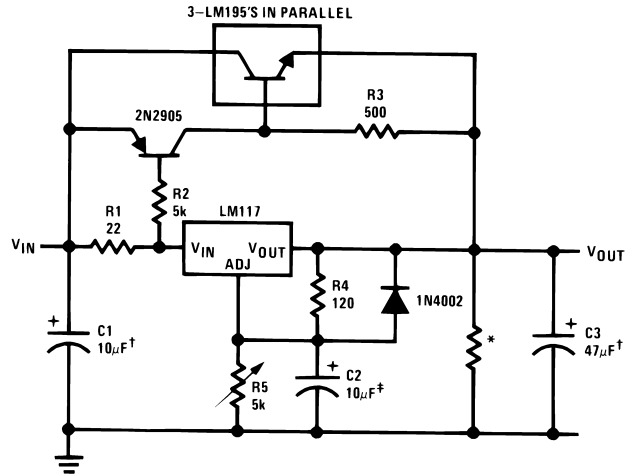
*Discharges C1 if output is shorted to ground

High Stability 10V Regulator



DS009063-11

High Current Adjustable Regulator



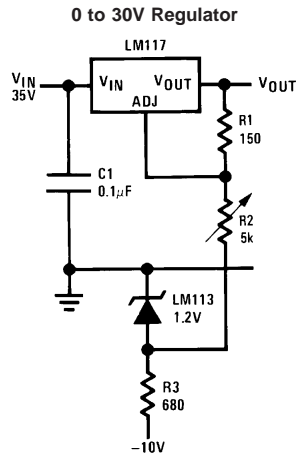
DS009063-12

‡Optional — improves ripple rejection

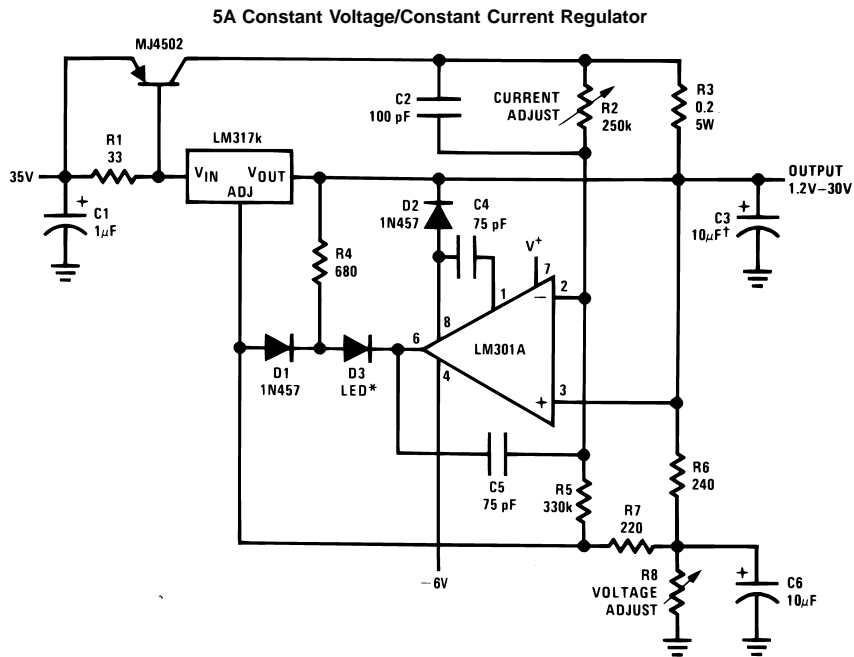
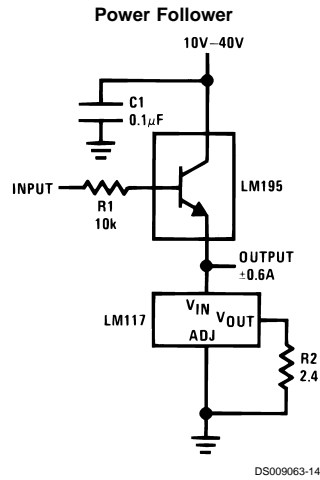
†Solid tantalum

*Minimum load current = 30 mA

Typical Applications (Continued)

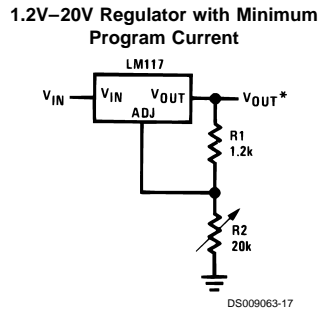
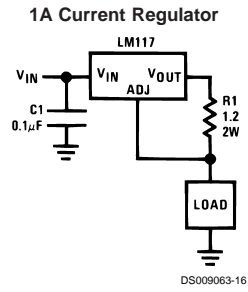


Full output current not available at high input-output voltages

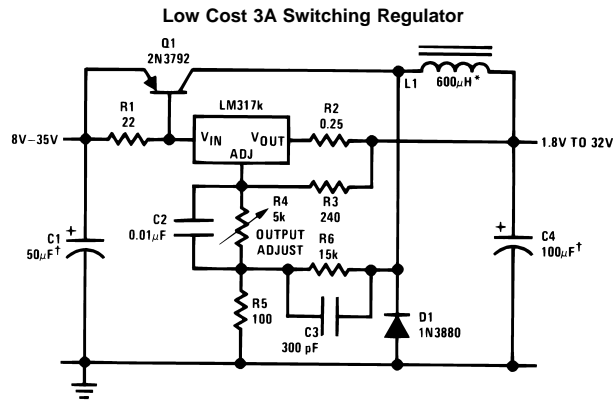
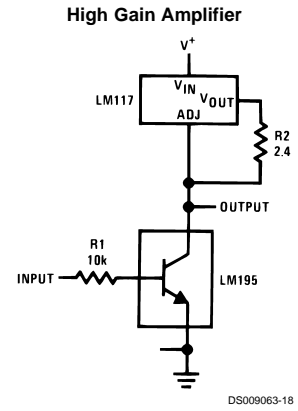


†Solid tantalum
*Lights in constant current mode

Typical Applications (Continued)



*Minimum load current = 4 mA

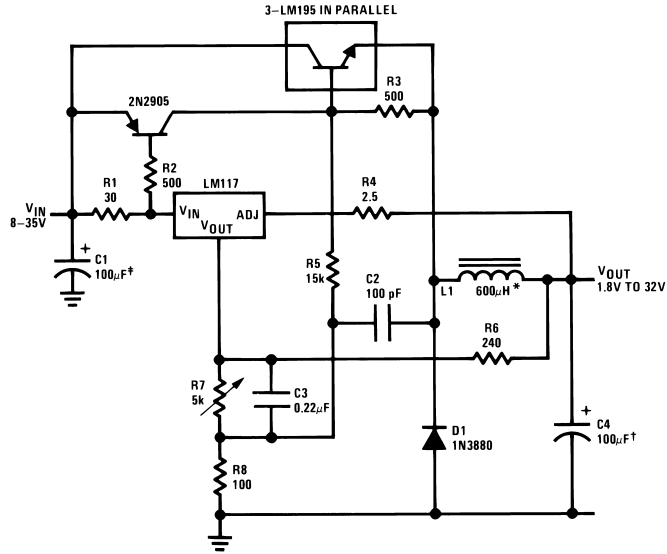


†Solid tantalum

*Core—Arnold A-254168-2 60 turns

Typical Applications (Continued)

4A Switching Regulator with Overload Protection

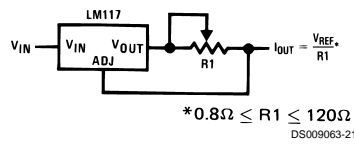


DS009063-20

†Solid tantalum

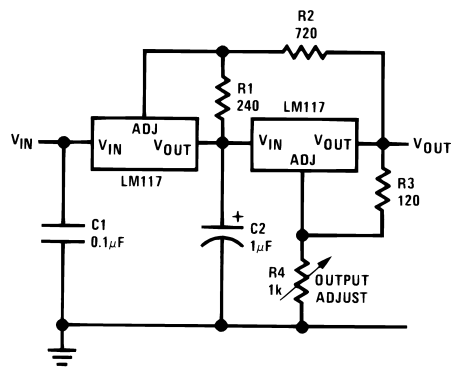
*Core — Arnold A-254168-2 60 turns

Precision Current Limiter



DS009063-21

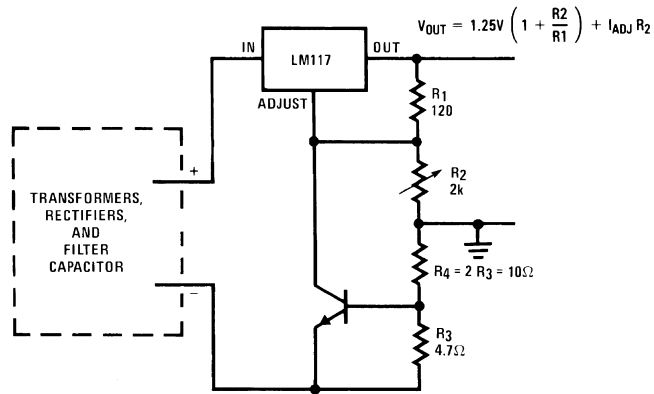
Tracking Preregulator



DS009063-22

Typical Applications (Continued)

Current Limited Voltage Regulator



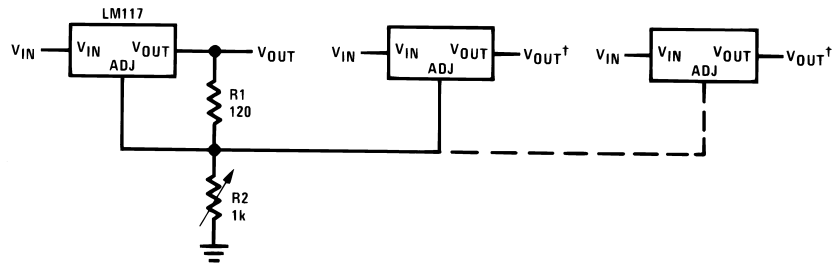
DS009063-23

— Short circuit current is approximately $\frac{600 \text{ mV}}{R_3}$, or 120 mA

(Compared to LM117's higher current limit)

— At 50 mA output only ¼ volt of drop occurs in R_3 and R_4

Adjusting Multiple On-Card Regulators with Single Control*

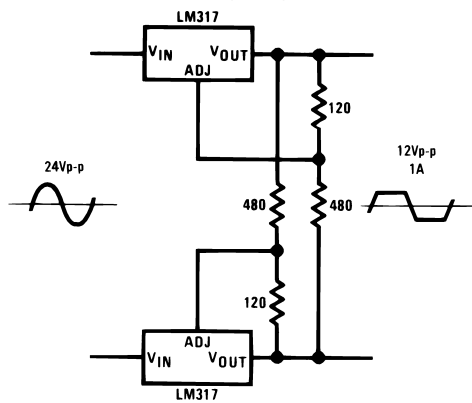


DS009063-24

*All outputs within $\pm 100 \text{ mV}$

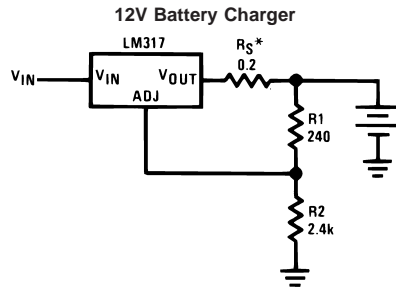
†Minimum load — 10 mA

AC Voltage Regulator



DS009063-25

Typical Applications (Continued)

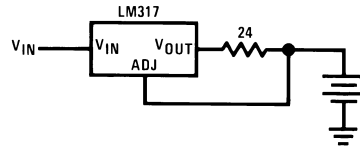


DS009063-26

* R_S —sets output impedance of charger: $Z_{OUT} = R_S \left(1 + \frac{R_2}{R_1} \right)$

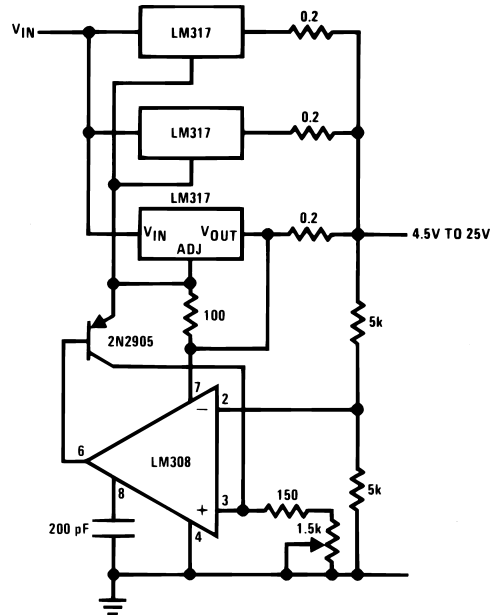
Use of R_S allows low charging rates with fully charged battery.

50 mA Constant Current Battery Charger



DS009063-27

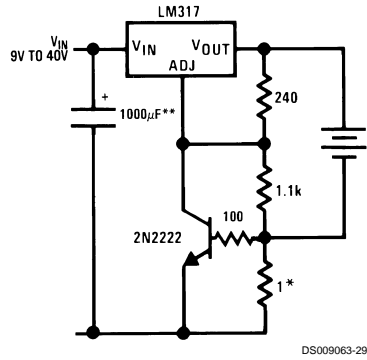
Adjustable 4A Regulator



DS009063-28

Typical Applications (Continued)

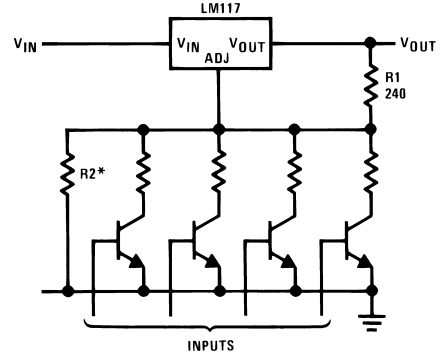
Current Limited 6V Charger



*Sets peak current (0.6A for 1Ω)

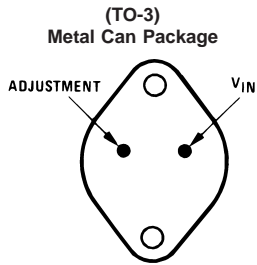
**The 1000 µF is recommended to filter out input transients

Digitally Selected Outputs

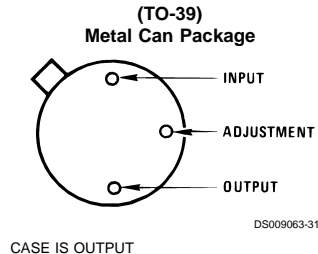


*Sets maximum V_{OUT}

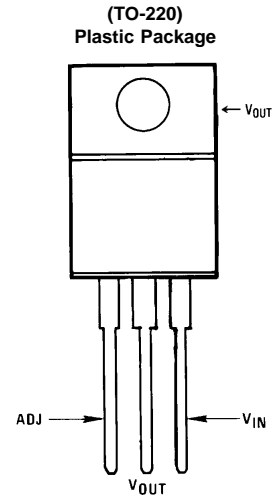
Connection Diagrams



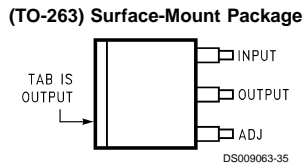
DS009063-30
 CASE IS OUTPUT
Bottom View
Steel Package
 Order Number LM117K STEEL
 or LM317K STEEL
 See NS Package Number K02A
 Order Number LM117K/883
 See NS Package Number K02C



DS009063-31
 CASE IS OUTPUT
Bottom View
 Order Number LM117H,
 LM117H/883,
 LM317AH or LM317H
 See NS Package Number H03A



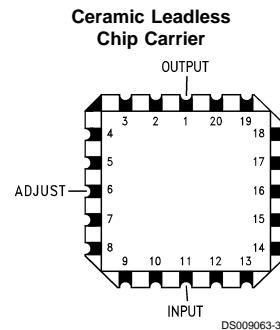
DS009063-32
Front View
 Order Number LM317AT or LM317T
 See NS Package Number T03B



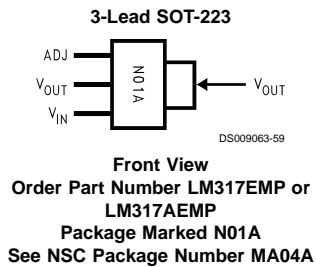
DS009063-35
Top View



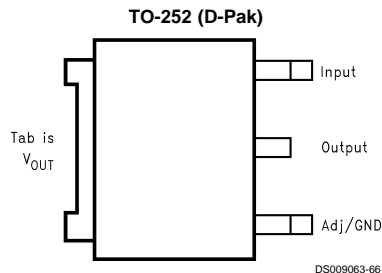
DS009063-36
Side View
 Order Number LM317S
 See NS Package Number TS3B



DS009063-34
Top View
 Order Number LM117E/883
 See NS Package Number E20A

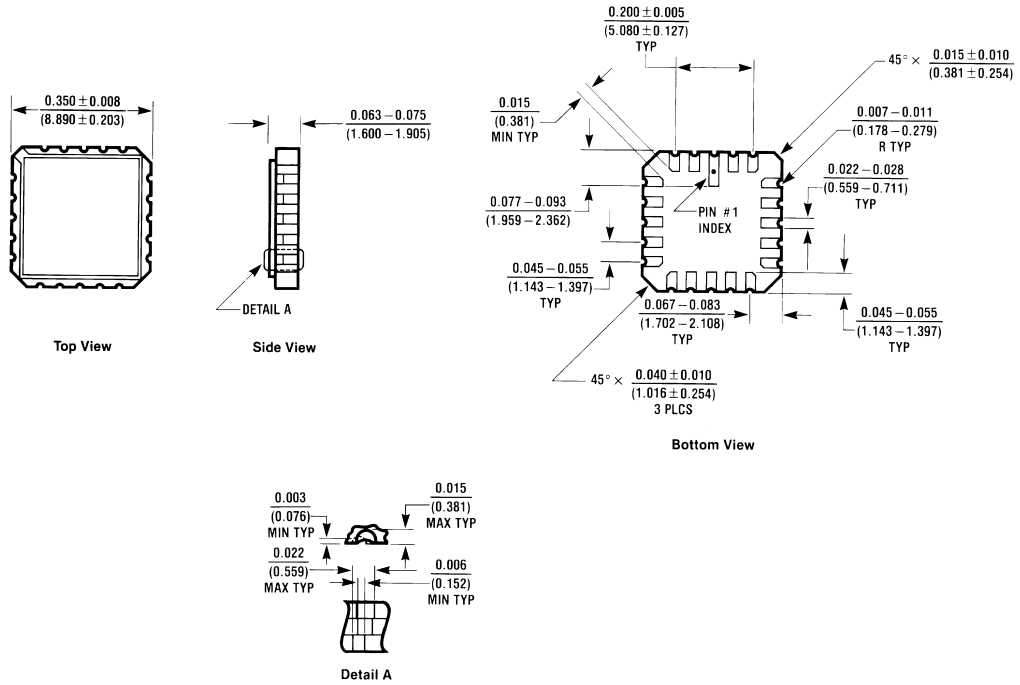


DS009063-59
Front View
 Order Part Number LM317EMP or
 LM317AEMP
 Package Marked N01A
 See NSC Package Number MA04A



DS009063-66
Front View
 Order Part Number LM317DT
 See NSC Package Number TD03B

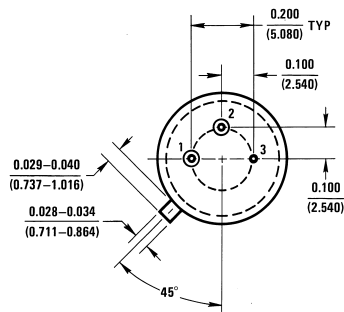
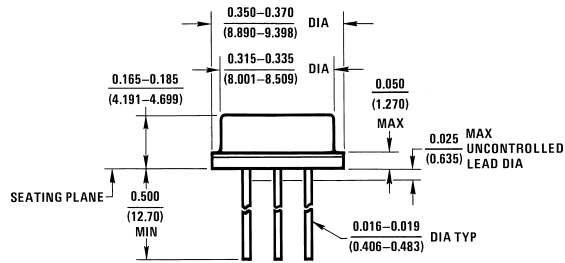
Physical Dimensions inches (millimeters) unless otherwise noted



E20A (REV D)

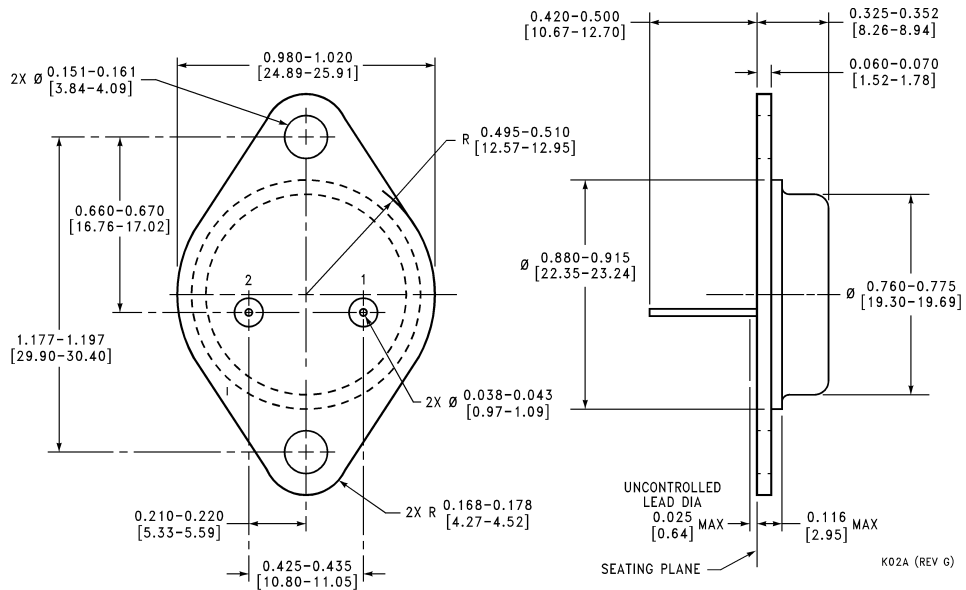
Ceramic Leadless Chip Carrier
Order Number LM117E/883
NS Package Number E20A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



H03A (REV B)

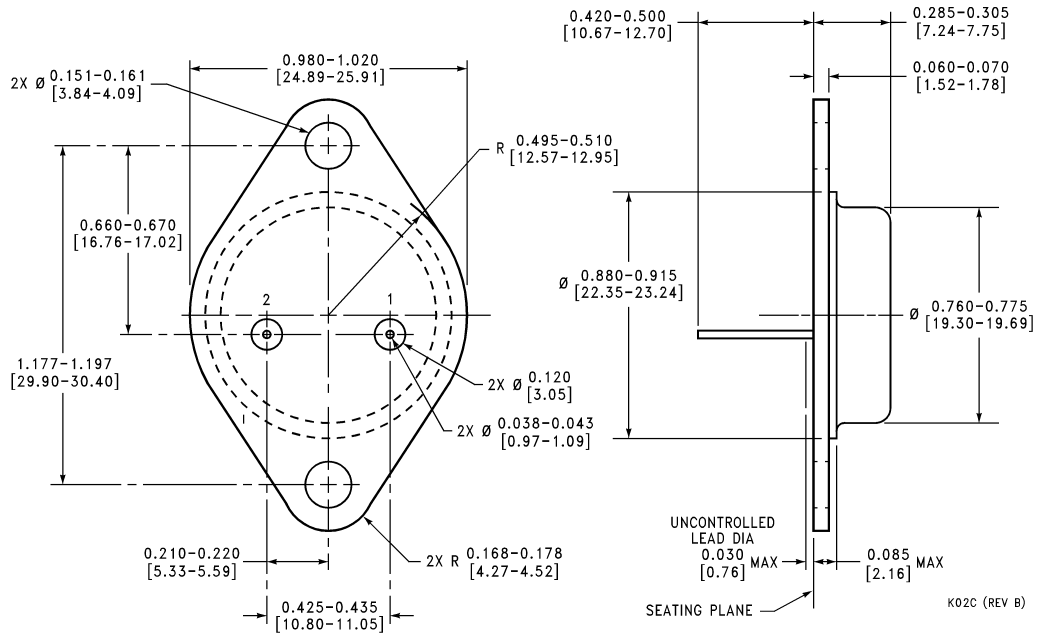
(TO-39) Metal Can Package
Order Number LM117H, LM117H/883, LM317AH or LM317H
NS Package Number H03A



K02A (REV G)

TO-3 Metal Can Package (K)
Order Number LM117K STEEL,
LM117K STEEL/883, or LM317K STEEL
NS Package Number K02A

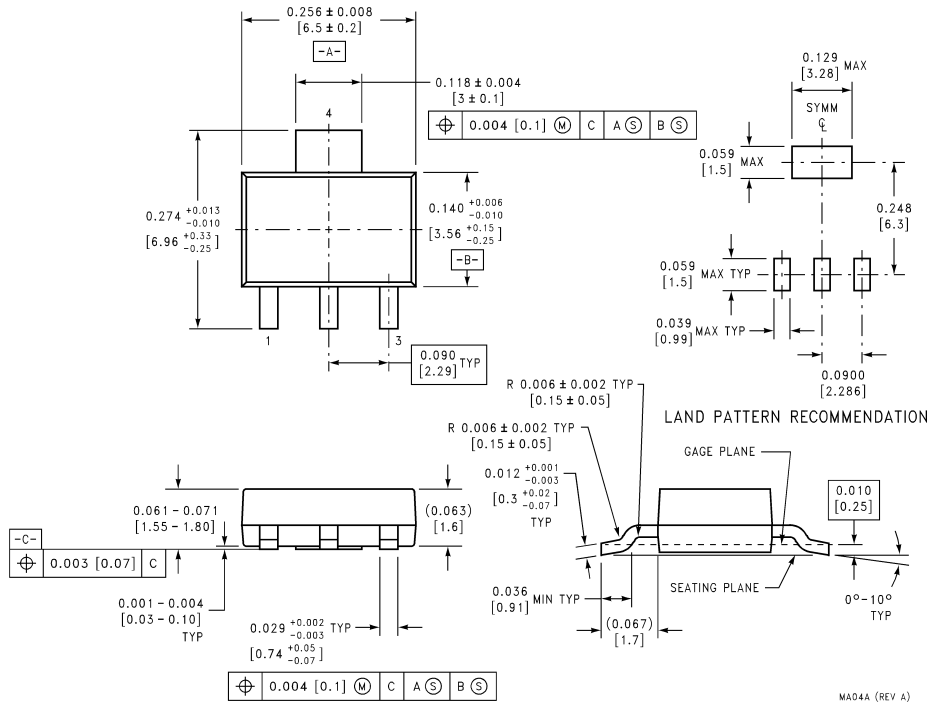
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



TO-3 Metal Can Package (K)
Mil-Aero Product
Order Number LM117K/883
NS Package Number K02C

K02C (REV B)

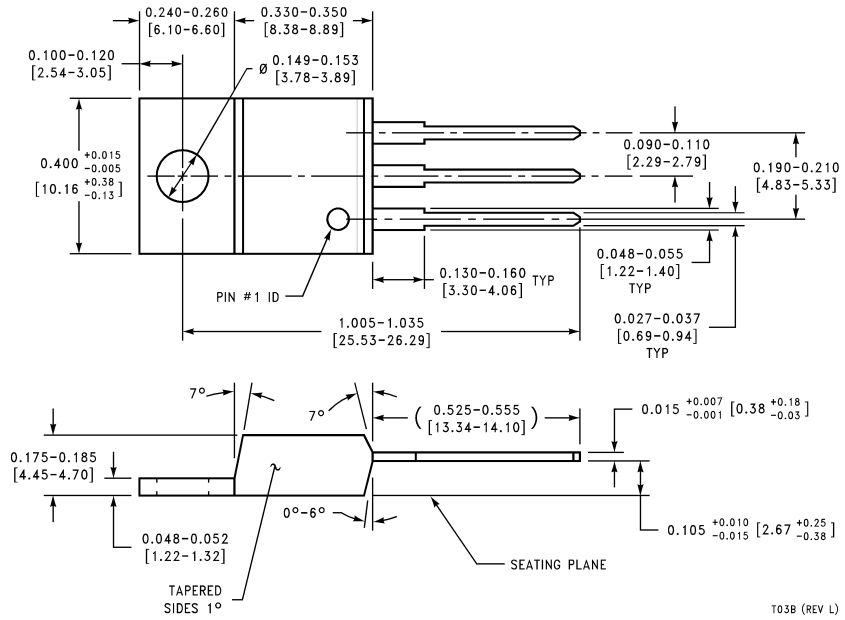
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



MA04A (REV A)

3-Lead SOT-223 Package
Order Number LM317AEMP or LM317EMP
NS Package Number MA04A

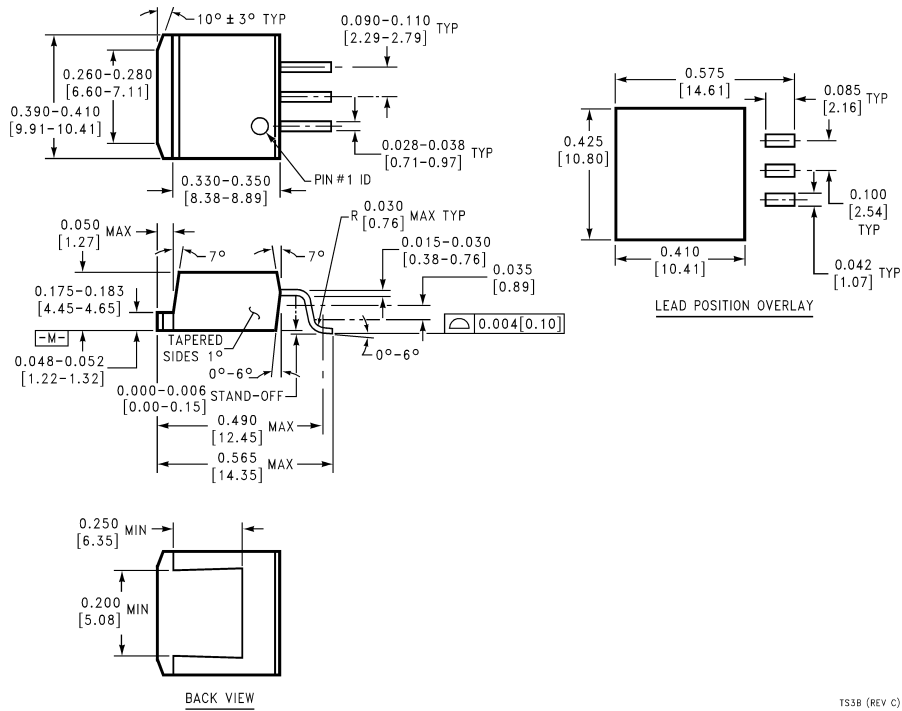
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



(TO-220) Outline Drawing
Order Number LM317AT or LM317T
NS Package Number T03B

T03B (REV L)

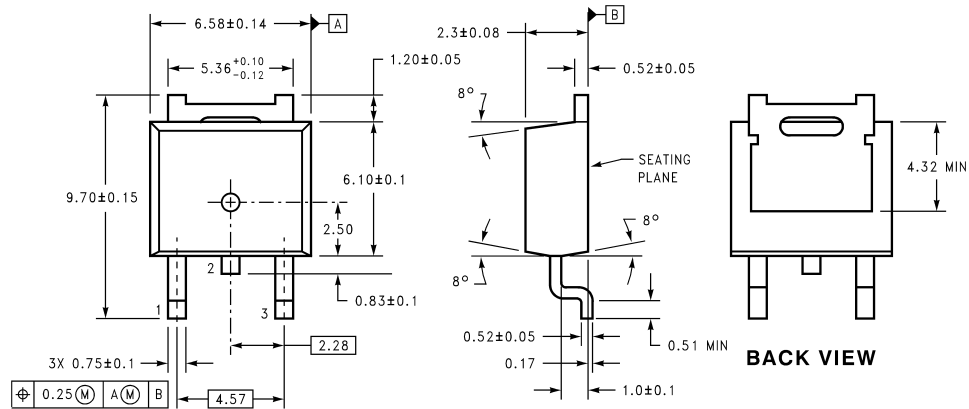
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



Order Number LM317S
NS Package Number TS3B

TS3B (REV C)

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



DIMENSIONS ARE IN MILLIMETERS

TD03B (REV A)

Order Number LM317MDT
 NS Package Number TD03B

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.



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 Fax: 1-800-737-7018
 Email: support@nsc.com

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National Semiconductor Japan Ltd.
 Tel: 81-3-5639-7560
 Fax: 81-3-5639-7507

Process Information

Process Information

Process Details

Fabrication Site: Fab 1, Greenock, NSUK
Process Technology: SLM
Wafer Diameter: 4 inches
Number of Masks: 7
Metalization: 0.5% Copper / Aluminum
Passivation: VOM & Nitride

Process Mask Steps

<u>Name</u>	<u>Mask #</u>
COLLECTOR	10
ISOLATION	20
BASE	30
EMITTER	40
CONTACT	50
METAL	60
PAD	70

Process Flow

1. Initial Oxidation
2. Laserscribe
3. Collector Mask
4. Collector Implant
5. Collector Drive
6. Epi Strip
7. Epi Growth
8. Epi Reoxidation
9. Iso Mask
10. Iso Pre-Deposition
11. Iso Drive
12. Strip Oxide
13. FTA Implant
14. FTA Re-Oxidation
15. Base Mask
16. Pre-Base Implant Oxidation
17. Base Implant
18. Base Drive
19. Emitter Mask
20. Emitter Pre-Deposition
21. Vapox Over Emitter
22. Getter
23. Post Getter dip
24. LIC Anneal
25. Contact Mask
26. Metal Deposition
27. Metal Mask
28. VOM
29. Nitride Deposition
30. Pad Mask
31. Anneal

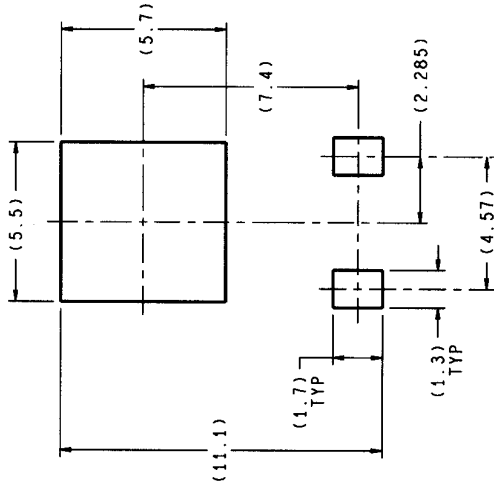
Packaging Information

Package Material

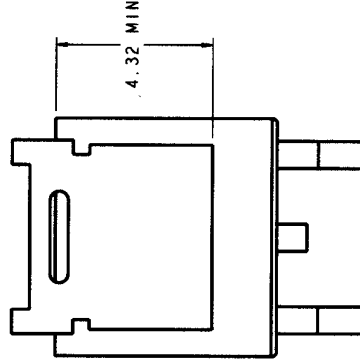
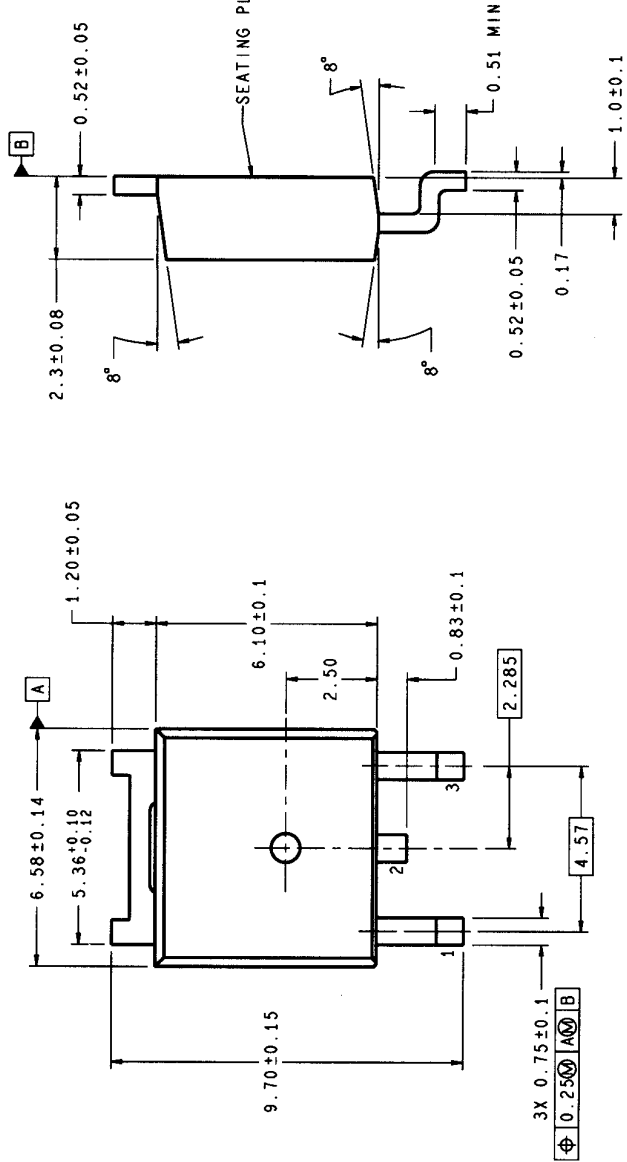
Generic Package Type	3 Lead TO-252 (D-Pak)
NS Package Number	TD03B
Mold Compound Type Manufacturer, Designation	EME-7200 Sumitomo
Lead Frame Material Manufacturer	TAMAC4
External Lead Frame Coating	Solder Plate Sn/Pb
Pins	3 Pins
Die Attach Material	Hi Lead Solder
Bond Wire	Gold, 1.5mils
Bond Type	Thermosonic Ball
Package Thermal	110°C/W

REVISIONS

LTR	DESCRIPTION	E.C.N	DATE	BY/APP'D
A	RELEASE TO DOCUMENT CONTROL	12120	10/23/1998	NOR/MS/SH
B	ADD LAND PATTERN RECOMMENDATION VIEW: DIA 2.285 WAS 2.28	12261	06/30/1999	MS/PS



LAND PATTERN RECOMMENDATION



APPROVALS	DATE	SCALE	SIZE	DRAWING NUMBER	REV
DRW: <i>AWP A.P.</i>	10/23/1998	N/A	C	(SC)MKT-TD03B	B
DTG. CH: <i>THANH LEQUANG</i>	06/30/1999	DO NOT SCALE DRAWING			
ENGR. CH: <i>PETER SPALDING</i>	06/30/1999	SHEET 1 of 1			

National Semiconductor
 2900 Semiconductor dr., Santa Clara, CA 95052-8090

TO-252, MOLDED, JEDEC,
 6.58 X 6.10 X 2.30mm BODY,
 3 LD, 2.28mm PITCH, S/M

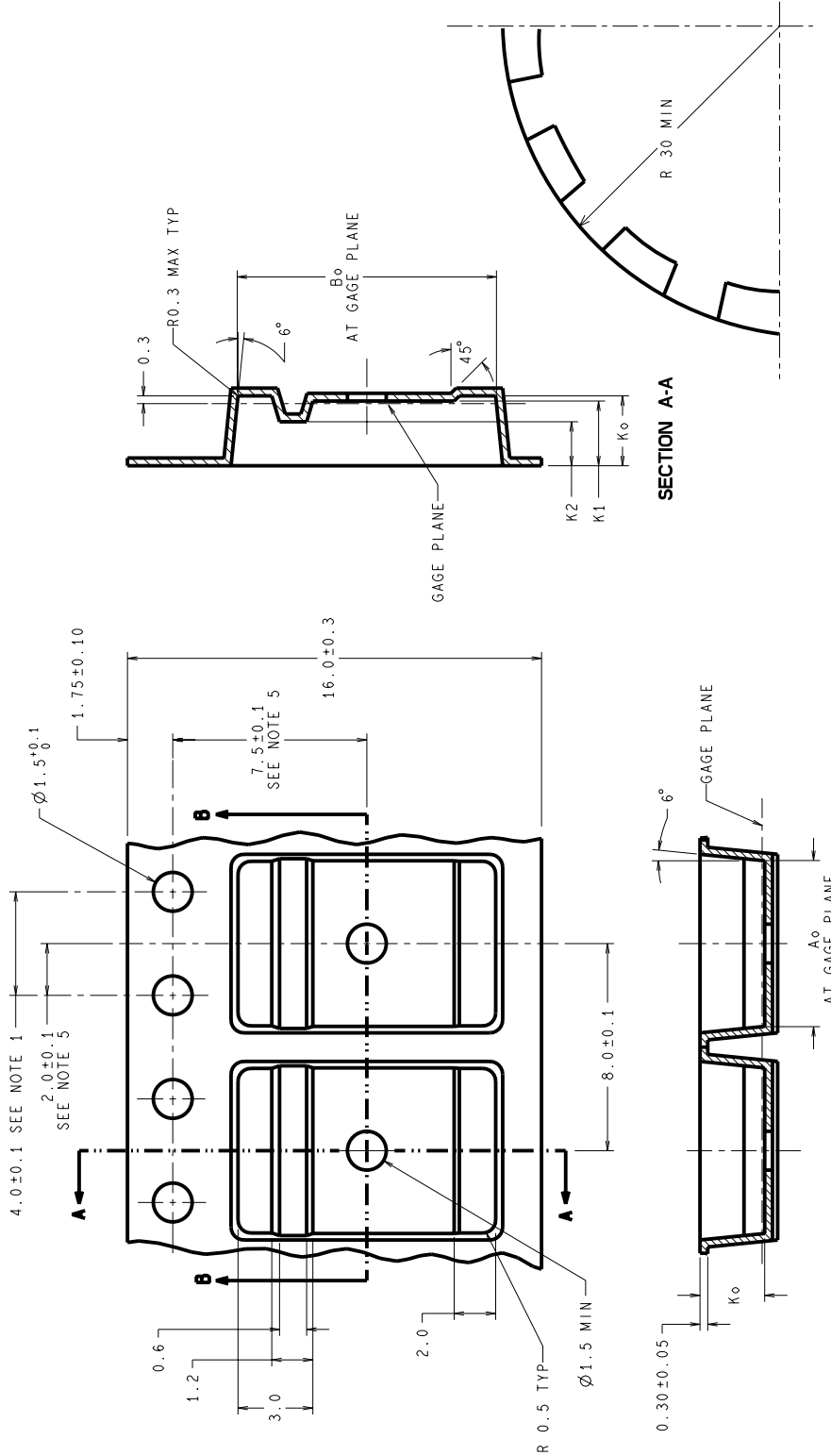
DIMENSIONS ARE IN MILLIMETERS

NOTES: UNLESS OTHERWISE SPECIFIED

- STANDARD LEAD FINISH:
 5.08 MICROMETERS MINIMUM
 LEAD/TIN 15/85 ON TAMAC 4.
- REFERENCE JEDEC REGISTRATION TO-252
 VARIATION AA, ISSUE C, DATED SEPT 1988.

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LTR	DESCRIPTION	E.C.N.	DATE
A	RELEASE TO DOCUMENT CONTROL	12123	11/16/1998
			NOR/MS/TG



ALLOWABLE BEND RADIUS
NOT TO SCALE

NOTES:

- CUMULATIVE PITCH TOLERANCE FOR FEEDING HOLES AND CAVITIES (CHIP POCKETS) NOT TO EXCEED .008 (0.20J) OVER 10 PITCH SPAN.
- THRU HOLE INSIDE CAVITY IS CENTERED WITHIN CAVITY.
- CAMBER NOT TO EXCEED 1mm IN 100mm.
- K₀ MEASURED FROM THE PLAN ON THE INSIDE BOTTOM OF THE POCKET TO THE TOP SURFACE OF THE CARRIER.
- POCKET POSITION RELATIVE TO SPROCKET HOLE MEASURED AS TRUE POSITION OF POCKET, NOT POCKET HOLE.

01	068785	375	6.9	10.5	2.7	2.5	1.7
OPT	STOCK #	LD COUNT	DIM A ₀	DIM B ₀	DIM K ₀	DIM K ₁	DIM K ₂
DIMENSIONS ARE IN MILLIMETERS							
UNLESS OTHERWISE SPECIFIED DIMENSIONS ARE IN INCHES. TOLERANCES ARE:		APPROVALS		DATE			
DECIMALS:		DRAWN		09/24/1998			
.XX ± 0.10		DPTG. CHK.		AOP. A.P.			
.XXX ± N/A		ANGLS:		± 1°			
.XXXX ± N/A		ENGR. CHK.		7.0 GDM 11/16/1998			
MATERIAL		PROJECTION		8X C (SC) 39-2259			
FINISH		SCALE		SIZE			
N/A		N/A		FORMERLY: N/A			
DO NOT SCALE DRAWING		DRAWING NUMBER		SHEET 1 of 1			
<p>National Semiconductor 2300, Semiconductor dr., Santa Clara, CA 95052-8090</p> <p>TAPE, EMBOSSED, 16MM, TO-251/252</p>							

Reliability Data

Reliability Test Report

File Number:
FEM19990001
Originator:
Suresh Kumar
Date: January 4, 1999

Purpose
Approvals
Qualification of T0252 (DPAK) package assembled in IDS

Reliability Engineer _____

Date _____

Mgr. Rel. Engineering _____

Date _____

Reference File Numbers

 REM199803515
 REM199804014
 Q19980613

Distribution List

Sharon Ko, KP Kok, CS Teoh

Abstract

This qualification is to qualify a new package T0252 (DPAK) which will be assembled in IDS. T0252 is a very new package to NSC. IDS is also a new subcontractor. Thus this qual plan will qualify T0252 package and IDS subcontractor at the same time.

Description

Test Request	Device Name	Sbgrp	Wafer Die Run	Fab Loc	Fab Line	Pkg Code	# Leads	Assy Loc	Date Cd	Mold Cmpnd
REM199803515	LM317TS	A	HM094456	UK	Bip Linear	T0252	003	IDS	9836	EME7200
REM199803515	LM317TS	B	HM094448	UK	Bip Linear	T0252	003	IDS	9836	EME7200
REM199803515	LM317TS	C	HM094495	UK	Bip Linear	T0252	003	IDS	9836	EME7200
REM199804014	LM2940TS-5.0	A	XXXXXXXXXX	UK	Bip Linear	T0252	003	IDS	9848	EME7200
REM199804014	LM2940TS-5.0	B	XXXXXXXXXX	UK	Bip Linear	T0252	003	IDS	9848	EME7200

Tests Performed
Preconditioning Flow

TMCL (-40/60C) 5cyc → Bake (125C) 24 hrs → THST (85C/85%) 168hrs → Reflow (235C) 3 passes → Flux Immersion → Rinse → Dry → ATE

Test: Autoclave Test (ACLV)

Test Request	Device	Sbgrp	Rel Humidity	Pressure	High Temp	LowTemp
REM199803515	LM317TS	A	100	15	121	
REM199803515	LM317TS	B	100	15	121	
REM199803515	LM317TS	C	100	15	121	

Timepoints:	Test Request	TP	Duration
	REM199803515	1	168

Test: High Temperature Storage test (bake) (HTSL)

Test Request	Device	Sbgrp	Rel Humidity	Pressure	High Temp	LowTemp
REM199803515	LM317TS	A			150	
REM199803515	LM317TS	B			150	
REM199803515	LM317TS	C			150	

Timepoints:	Test Request	TP	Duration			
	REM199803515	1	168			
	REM199803515	2	500			
	REM199803515	3	1000			
Test: Operating Life Test (Static) (SOPL)						
Test Request	Device	Sbgrp	Rel Humidity	Pressure	High Temp	LowTemp
REM199803515	LM317TS	A			125	
REM199803515	LM317TS	B			125	
REM199803515	LM317TS	C			125	
Timepoints:	Test Request	TP	Duration			
	REM199803515	1	168			
	REM199803515	2	500			
	REM199803515	3	1000			
Test: Power Cycle (PRCL)						
Test Request	Device	Sbgrp	Rel Humidity	Pressure	High Temp	LowTemp
REM199804014	LM2940TS-5.0	A			125	25
REM199804014	LM2940TS-5.0	B			125	25
Timepoints:	Test Request	TP	Duration			
	REM199804014	1	15000			
	REM199804014	2	30000			
Test: Temperature Cycle (TMCL)						
Test Request	Device	Sbgrp	Rel Humidity	Pressure	High Temp	LowTemp
REM199803515	LM317TS	A			150	-65
REM199803515	LM317TS	B			150	-65
REM199803515	LM317TS	C			150	-65
Timepoints:	Test Request	TP	Duration			
	REM199803515	1	500			
	REM199803515	2	1000			
Test: Temperature Humidity Bias Test (THBT)						
Test Request	Device	Sbgrp	Rel Humidity	Pressure	High Temp	LowTemp
REM199803515	LM317TS	A	85		85	
REM199803515	LM317TS	B	85		85	
REM199803515	LM317TS	C	85		85	
Timepoints:	Test Request	TP	Duration			
	REM199803515	1	168			
	REM199803515	2	500			
	REM199803515	3	1000			

Results/Discussion

Test: Autoclave Test (ACLV)							
Test Request	Device	Sbgrp	TP	Duration	Sample Size	Rejects	
REM199803515	LM317TS	A	0	Precond	50	0	
REM199803515	LM317TS	A	1	168	50	0	
REM199803515	LM317TS	B	2	Precond	50	0	
REM199803515	LM317TS	B	1	168	50	0	
REM199803515	LM317TS	C	2	Precond	50	0	
REM199803515	LM317TS	C	1	168	50	0	
Test: High Temperature Storage test (bake) (HTSL)							
Test Request	Device	Sbgrp	TP	Duration	Sample Size	Rejects	
REM199803515	LM317TS	A	1	168	100	0	
REM199803515	LM317TS	A	2	500	100	0	
REM199803515	LM317TS	A	3	1000	100	0	
REM199803515	LM317TS	B	1	168	100	0	
REM199803515	LM317TS	B	2	500	100	0	
REM199803515	LM317TS	B	3	1000	100	0	

REM199803515	LM317TS	C	1	168	100	0
REM199803515	LM317TS	C	2	500	100	0
REM199803515	LM317TS	C	3	1000	100	0
Test: Operating Life Test (Static) (SOPL)						
Test Request	Device	Sbgrp	TP	Duration	Sample Size	Rejects
REM199803515	LM317TS	A	1	168	100	0
REM199803515	LM317TS	A	2	500	100	0
REM199803515	LM317TS	A	3	1000	100	0
REM199803515	LM317TS	B	1	168	100	0
REM199803515	LM317TS	B	2	500	100	0
REM199803515	LM317TS	B	3	1000	100	0
REM199803515	LM317TS	C	1	168	100	0
REM199803515	LM317TS	C	2	500	100	0
REM199803515	LM317TS	C	3	1000	100	0
Test: Temperature Humidity Bias Test (THBT)						
Test Request	Device	Sbgrp	TP	Duration	Sample Size	Rejects
REM199803515	LM317TS	A	1	168	100	0
REM199803515	LM317TS	A	2	500	100	0
REM199803515	LM317TS	B	1	168	100	0
REM199803515	LM317TS	B	2	500	100	0
REM199803515	LM317TS	C	1	168	100	0
REM199803515	LM317TS	C	2	500	100	0
Test: Temperature Cycle (TMCL)						
Test Request	Device	Sbgrp	TP	Duration	Sample Size	Rejects
REM199803515	LM317TS	A	1	500	100	0
REM199803515	LM317TS	A	2	1000	100	0
REM199803515	LM317TS	B	1	500	100	0
REM199803515	LM317TS	B	2	1000	100	0
REM199803515	LM317TS	C	1	500	100	0
REM199803515	LM317TS	C	2	1000	100	0
Test: Power Cycle (PRCL)						
Test Request	Device	Sbgrp	TP	Duration	Sample Size	Rejects
REM199804014	LM2940TS-5.0	A	1	15000	77	0
REM199804014	LM2940TS-5.0	B	1	15000	77	0

Conclusion

Based on the qualification results, the TO252 (DPAK) package is qualified to be assembled. IDS being the subcontractor is also qualified to assemble this package. Based on the moisture sensitivity test done, this package is qualified as a level 1 moisture sensitive package.